Application/Control No. Applicant(s)/Patent Under Reexamination 10/770,652 LINDENMEIER, HEINZ Notice of References Cited Examiner Art Unit Page 1 of 1 Tho G. Phan 2821 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,229,495 B1 05-2001 Lopez et al. 343/791 US-6,078,295 A 06-2000 Rawle, Walter D. 343/730 US-6,140,969 A Lindenmeier et al. С 10-2000 343/700MS US-5,610,620 A 03-1997 Stites et al. D 343/725 US-4,443,803 A 04-1984 DeSantis et al. Ε 343/749 US-F US-G US-Н US-US-J K US-US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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